



Issue Classification 	Application/Control No. 10/521,683	Applicant(s)/Patent under Reexamination SCHMIDT ET AL.
	Examiner Hai H. Huynh	Art Unit 3747

ISSUE CLASSIFICATION													
ORIGINAL					INTERNATIONAL CLASSIFICATION								
CLASS		SUBCLASS			CLAIMED					NON-CLAIMED			
123		143B			F	02	P	23	/04				/
CROSS REFERENCES								/				/	
CLASS	SUBCLASS (ONE SUBCLASS PER BLOCK)							/				/	
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					 Hai Huynh 11/30/06 (Primary Examiner) (Date)					Total Claims Allowed: 9			
(Assistant Examiner) (Date)										O.G. Print Claim(s)		O.G. Print Fig.	
(Legal Instruments Examiner) (Date)										1		1	

<input type="checkbox"/> Claims renumbered in the same order as presented by applicant										<input type="checkbox"/> CPA		<input type="checkbox"/> T.D.		<input type="checkbox"/> R.1.47		
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